Search					earch Notes							

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,751	DAJER ET AL.	
Examiner	Art Unit	
James D. Stein	2874	

SEARCHED					
Class	Subclass	Date	Examiner		
385	14,15,24	6/28/2005	JDS		
	,				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See attached EAST search history	6/28/2005	JDS		
IEEE, INSPEC: backplane, radio, card, board, remote	6/28/2005	JDS		